

Search Notes 	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/661,615	INOUE ET AL.	
	Examiner	Art Unit	
	Scott B. Geyer	2812	

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
438	386, 387	3/4/2005	SBG
438	396	3/4/2005	SBG